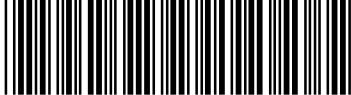


<b>Application Number</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/711,933	WU ET AL.	
Examiner	HENOK G. HEYI	Art Unit	2627